IAP20 RESIGNATION BO75-1025

## IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Tomohiko SATONAGA et al

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed January 11, 2006

Examiner

METHOD FOR PRODUCING CRYSTAL OF FLUORIDE

# INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

January 11, 2006

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

### I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

#### II. COPIES

- Copies of the U.S. patents or publications are not submitted since the USPTO has waived their submission for applications filed after June 30, 2003.
- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

# III. CONCISE EXPLANATION OF THE RELEVANCE OF THE RELEVANC

a. DOCUMENTS IN THE ENGLISH LANGUAGE

The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy.

b. DOCUMENTS NOT IN THE ENGLISH LANGUAGE

A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:

The English abstracts are enclosed.

An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).

d. OTHER

The following additional information is provided for the Examiner's consideration.

#### FEES

This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.

If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.

Respectfully submitted,

YOUNG & THOMPSON

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(703) 979-4709

BC/lpp

Enclosures:  $\boxtimes$  Form PTO-1449(s)

□ Documents

\_\_\_\_Other:\_\_\_\_\_

INFORMATION	<b>DISCLOSURE</b>	CITATION
IN AN	APPLICATION	l

Attorney Docket No.: 8075-1025

Application No.:

**NEW NATIONAL PHASE** 

Applicant:

Tomohika Sationa Gaetal 10 11 JAN 2006

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		FOREIGN PA	TENT DOCUMENTS				
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	JP 8-259375	10/8/1996	JAPAN				
	JP 10-265293	10/6/1998	JAPAN				
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t	OTHER DOCUMEN	ITS (including A	Author, Title, Date, Pertin	ent Pages	Etc )		
	T. FUKUDA et al., Crystal grov	_				er	·
	applications, Journal of Materi	als Science, Mate	erials in Electronics, 1999,	Vol. 10, pag	es 571 to 5	580	
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\* English language abstract provided for the Examiner's convenience

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